## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10511456	PAYNE, PATRICK
Examiner	Art Unit
Kim, Edward J	2455

SEARCHED					
Class		Subclass	Date	Examiner	
709	201-253			Edward J Kim	
379	200-207			Edward J Kim	
455	1-575.9			Edward J Kim	

SEARCH NOTES				
Search Notes	Date	Examiner		
Also searched the Derwent, JPO, EPO, and IBM databases		Edward J Kim		
Also conducted inventor search on Patrick Payne		Edward J Kim		
Updated East Search	10/18/2007	EJK		
Discussed with SPE	10/18/2007	EJK		
Updated search.	07/11/2008	EJK		
Reviewed case according to the Amendment	05/01/2009	EJK		

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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